

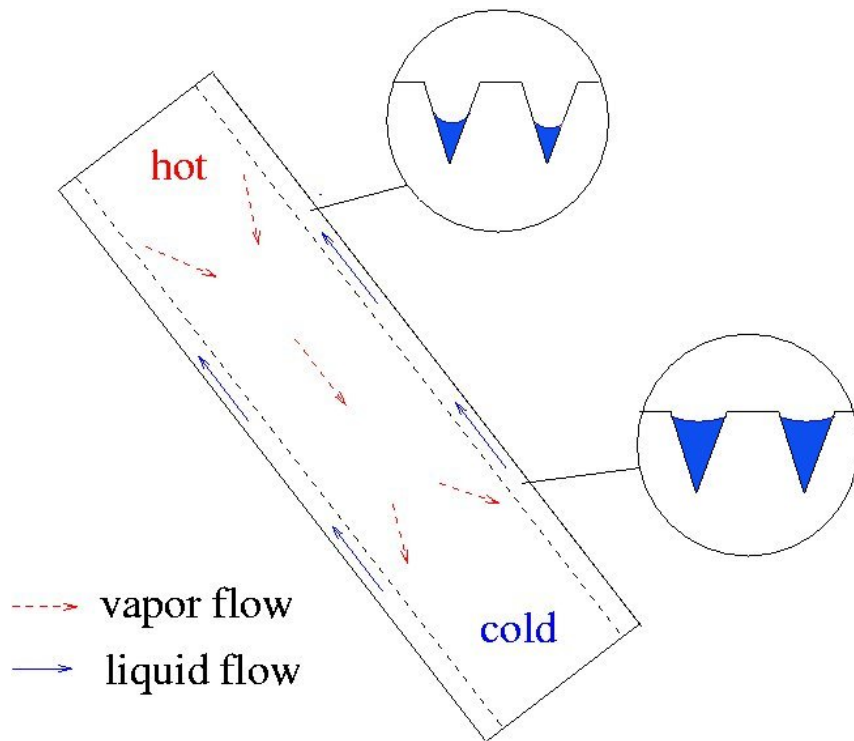
# **Electrostatic effects and evaporation near apparent contact lines**

Christiaan Ketelaar and Vladimir Ajaev

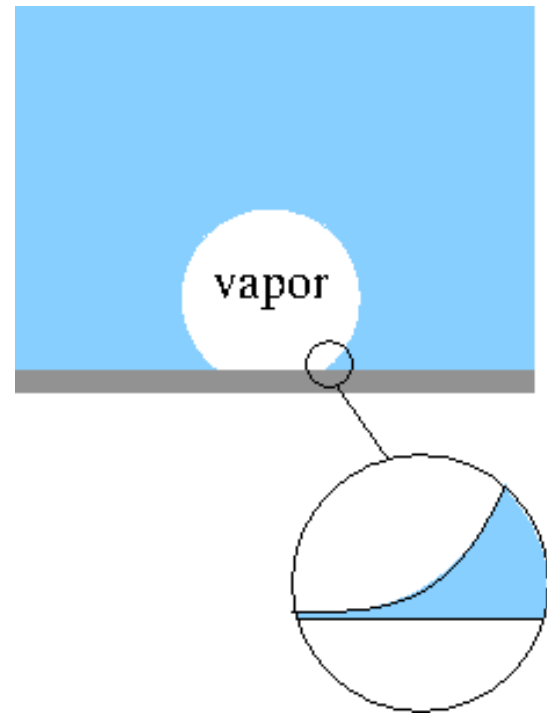
Southern Methodist University

# Motivating applications

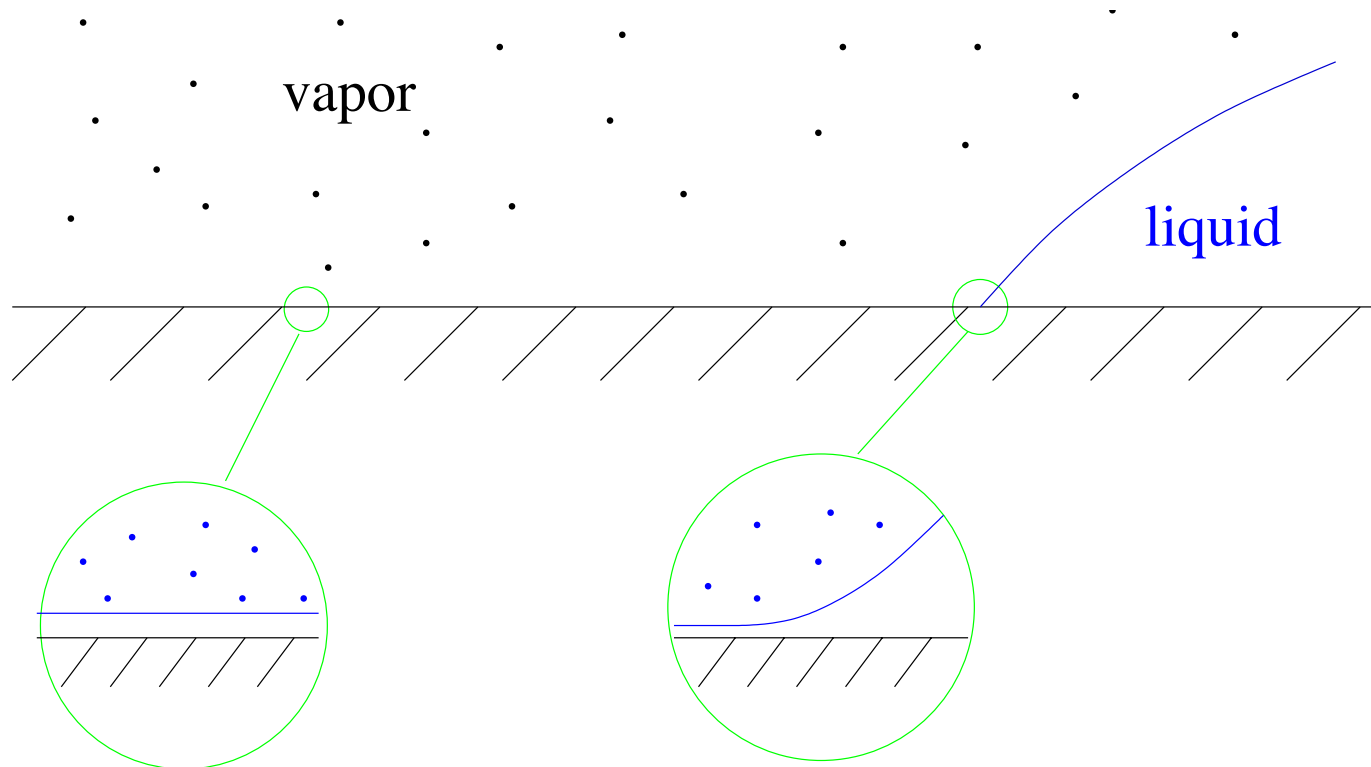
## Micro heat pipes



## Pool boiling



# Apparent contact lines

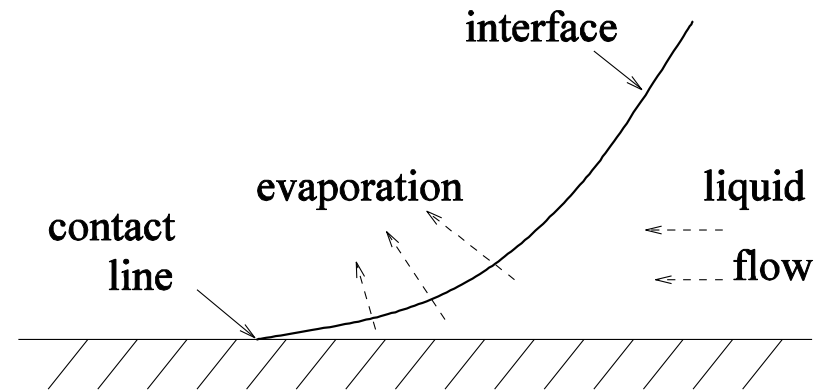


- “Dry” area is covered by ultra-thin film
- Apparent contact line is a transition zone

# Models of evaporation

Heat flux:

$$J^* = \frac{k\Delta T - \delta^*(\Delta P + \Pi)}{H}$$



Solutions with van der Waals disjoining pressure:

Potash & Wayner (1972), Moosman & Homsy (1980),

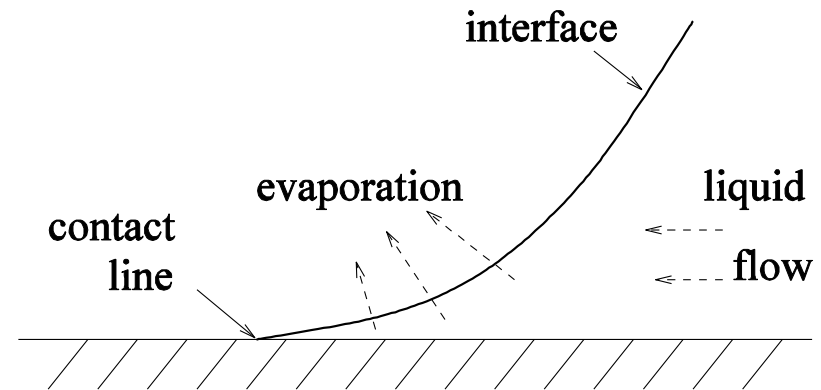
Morris (2001), Ajaev et al. (2002), ...

Electrostatic effects - ?

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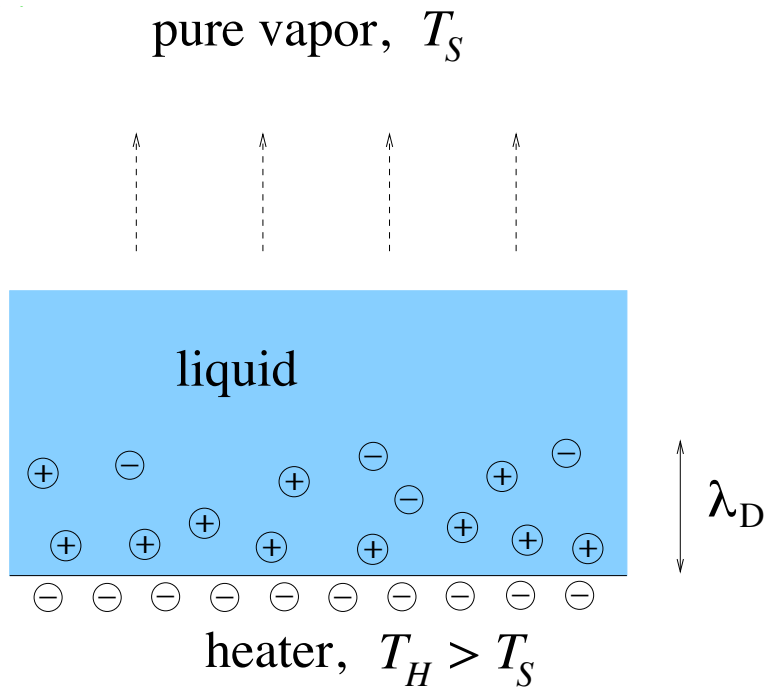
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Morris (2001), Ajaev et al. (2002), ...

Electrostatic effects - ? Mazzoco & Wayner (1999)

# Electric field in the film



$$\psi_{yy} = \kappa^2 \sinh \psi$$

$$\psi(x, 0, t) = \psi_0$$

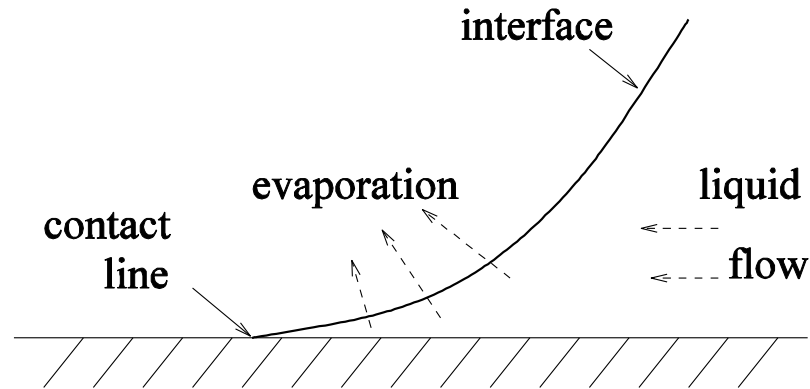
$$\psi_y(x, h, t) = \kappa q$$

$$\lambda_D = \left( \frac{2n_0 e^2}{\epsilon k_B T} \right)^{-1/2}$$

Parameters:

$$\kappa = \frac{d}{\lambda_D}, \quad \psi_0, \quad q$$

# Evaporation and viscous flow



- Lubrication-type velocity profile ( $d \ll L$ )
- Uniformly heated substrate
- Small capillary number
- One-sided model of evaporation

# Non-dimensional model

Evaporative flux:

$$J = \frac{\delta \left( \frac{1}{2} \kappa^2 Q q^2 - h_{xx} - \kappa^2 Q \cosh \tilde{\psi} - \frac{\alpha}{h^3} \right) + T_0}{K + h}$$

Equation for thickness:

$$h_t + J + \frac{1}{3} \left[ h^3 \left( h_{xx} + \kappa^2 Q \cosh \tilde{\psi} + \frac{\alpha}{h^3} \right) \right]_x - \frac{1}{2} \kappa Q q \left[ h^2 \tilde{\psi}_h h_x \right]_x = 0$$

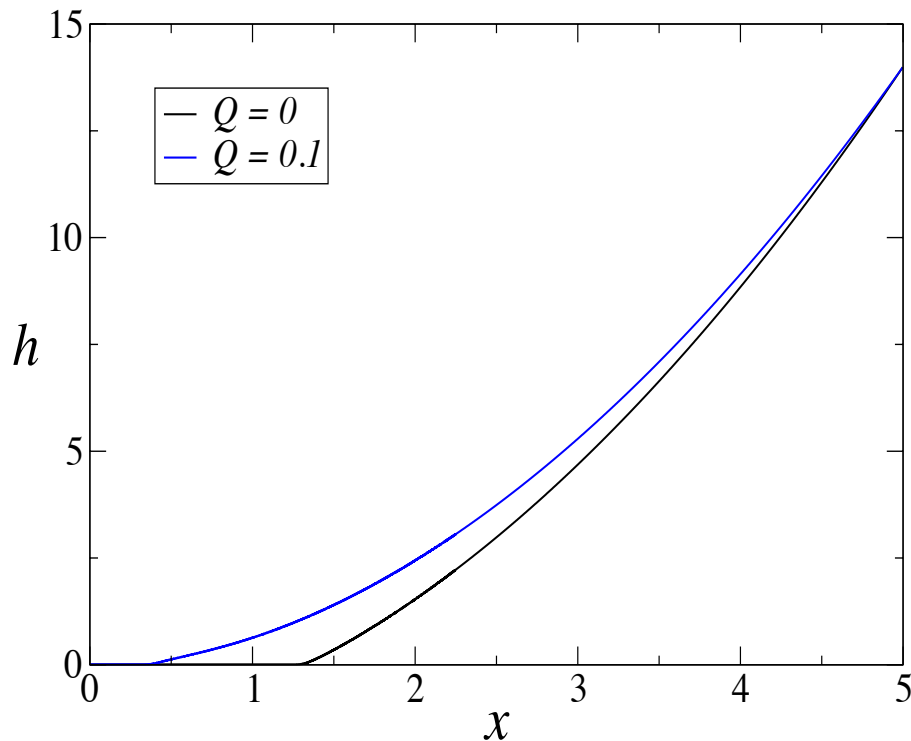
**Key parameters:**  $\kappa$ ,  $\psi_0$ ,  $q$ ,  $Q = \frac{\varepsilon}{\sigma R_0} \left( \frac{k_B T_S}{e} \right)^2$ ,  $T_0$ ,  $\alpha$ ,  $K$ ,  $\delta$



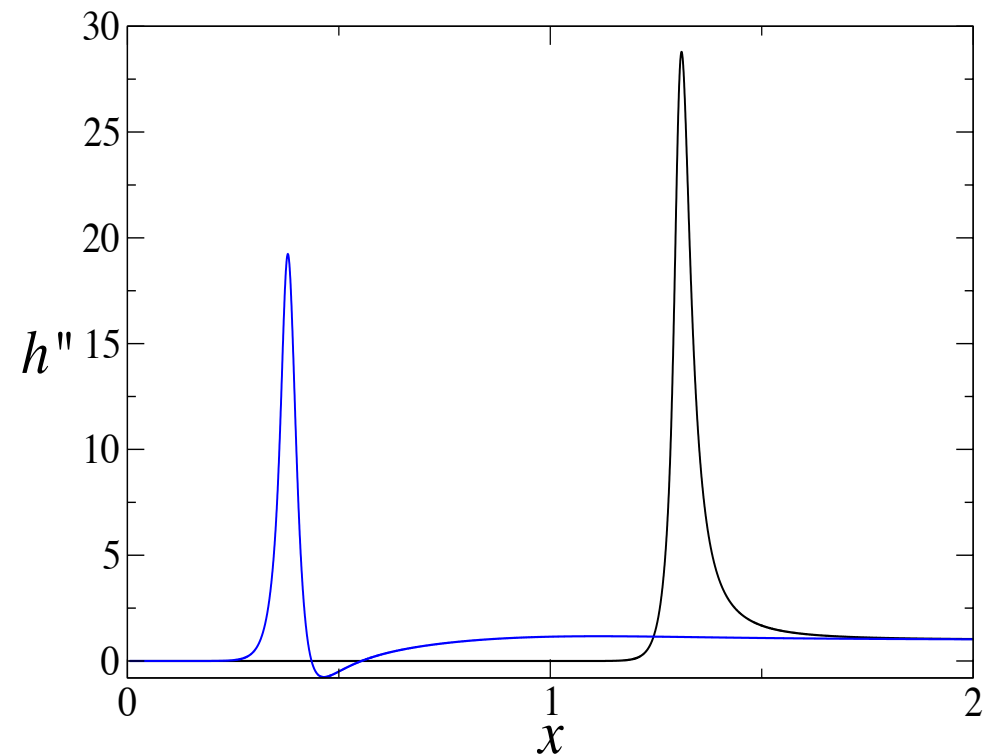
# Local liquid-vapor interface shapes

Consider steady-state solutions:  $h_t = 0$

Film thickness



Curvature



$$q = 0.1, \quad \psi_0 = -5, \quad T_0 = 0.1, \quad q = -0.04, \quad \kappa = 3, \quad K = 0.1, \quad \delta = 10^{-4}, \quad \alpha = 10^{-3}$$

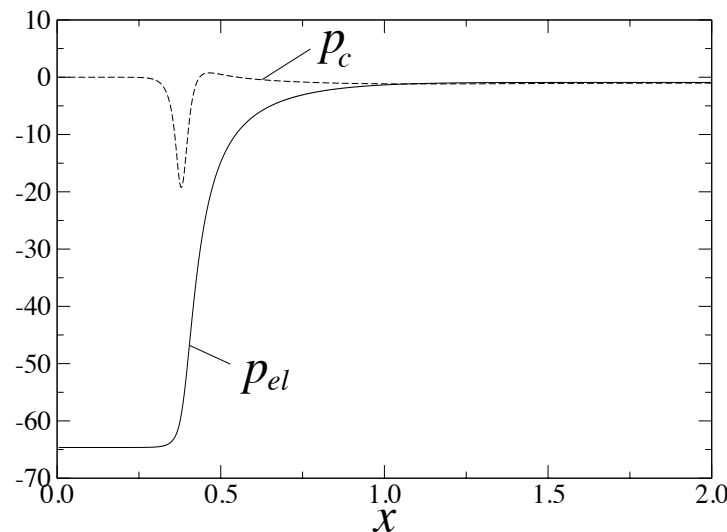
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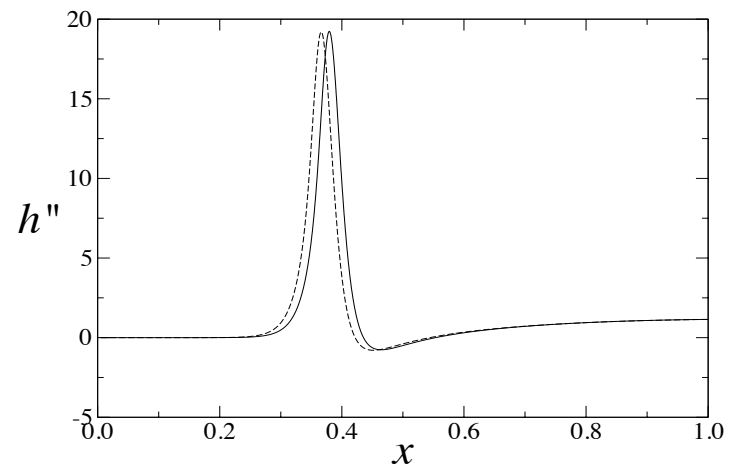


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- Shift in local saturation temperature – small
- Extra term in normal stress balance

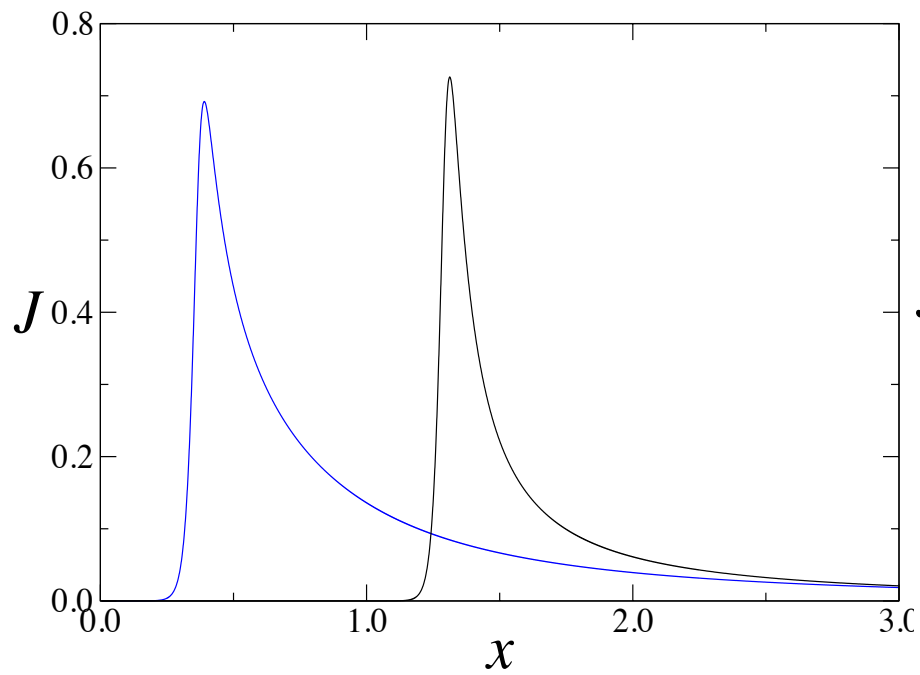
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- Shear stress balance modification

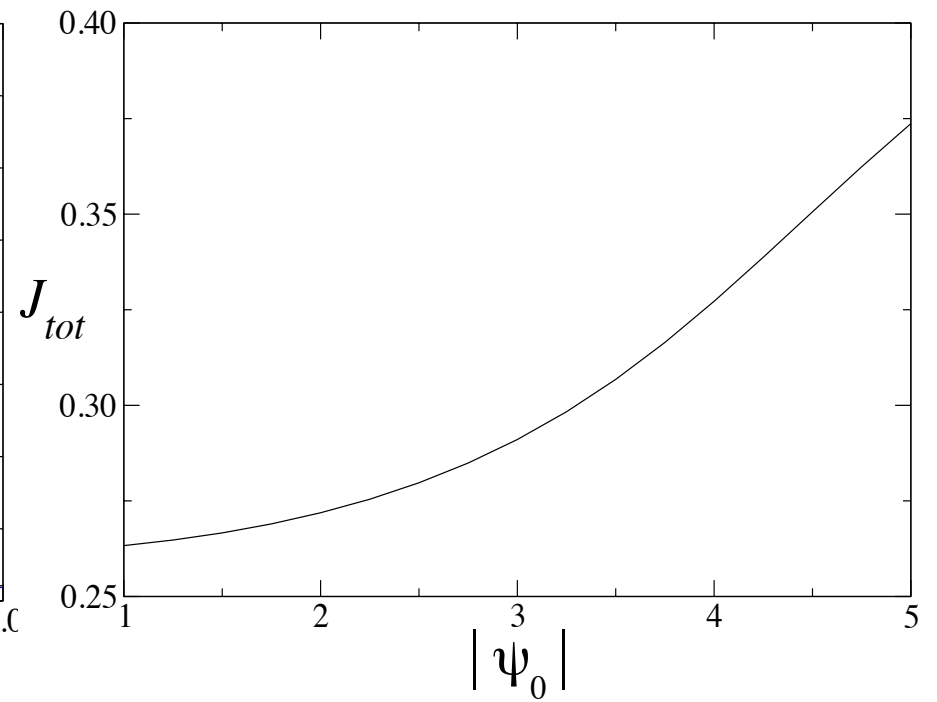


# Evaporation rates

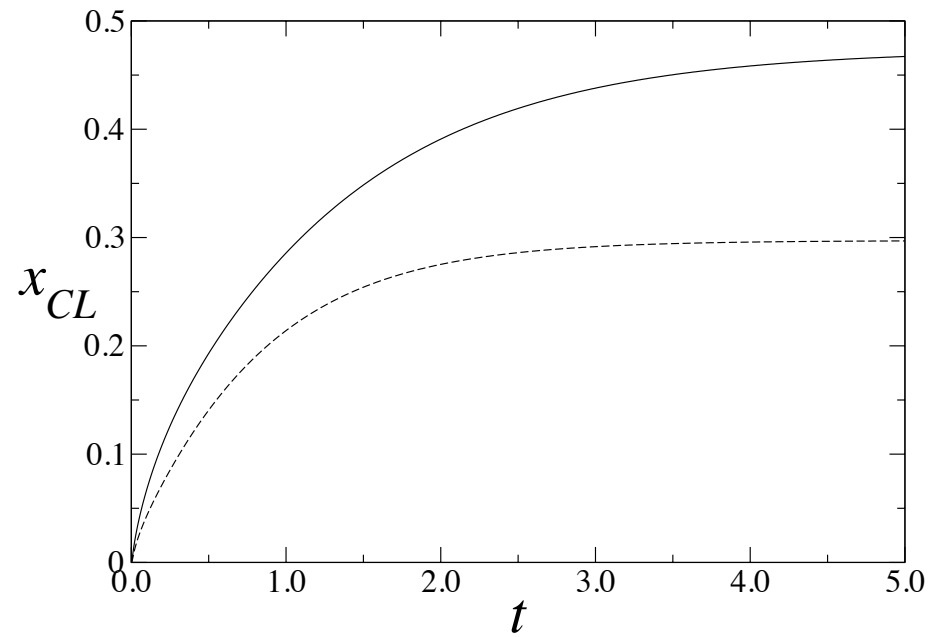
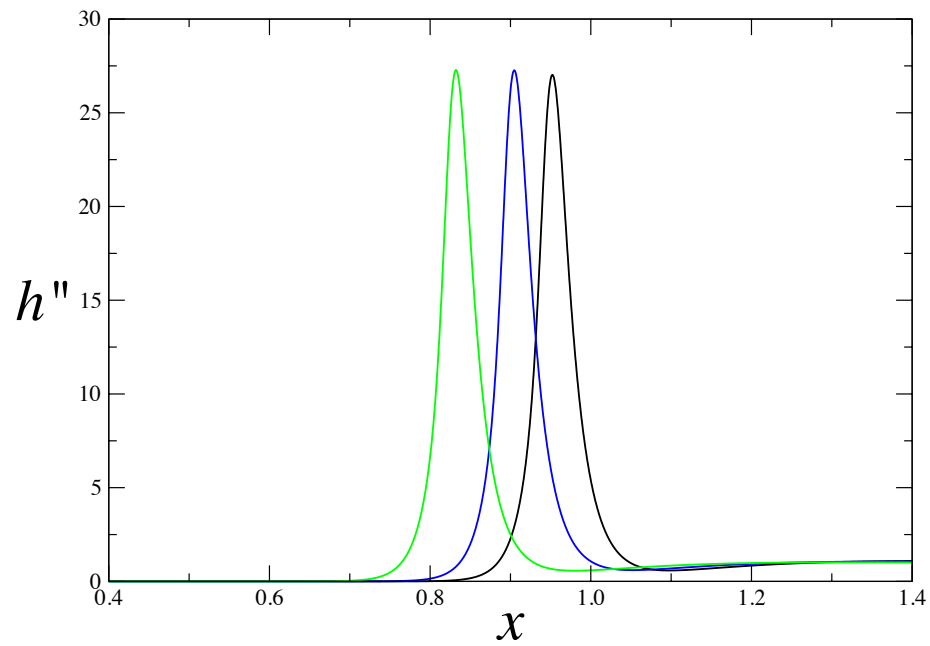
Local flux profile



Integrated evaporation rate



# Moving contact lines



# Conclusions

- A lubrication-type model is developed for evaporating meniscus of aqueous solution
- Electrostatic effects are described via nonlinear Poisson-Boltzmann equation and influence *both* normal and tangential interfacial stress conditions
- Curvature and flux profiles near apparent contact line are wider due to electrostatic effects
- Total evaporation rate is increased